

JNTE 10

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OPTICAL COUPLING OF SOI WAVEGUIDES AND III-V PHOTODETECTORS



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http://vtt.fi/research/technology/micro_and_nanophotonics.jsp

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<http://photonics.intec.ugent.be>



**ESA/ESTEC
(ARTES 5)**



SEVENTH FRAMEWORK
PROGRAMME

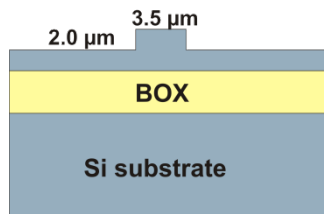


- **Background and motivation**
- **Coupling light from fiber to silicon waveguides**
 - Principle of grating couplers
- **Photodiode design**
 - Photodiode design for high speed
 - Prism coupling
 - Evanescent coupling
- **Fabrication**
 - Prism photodiode fabrication
 - Heterogeneous integration
- **Performance**
 - Prism photodiodes, discrete and integrated (OTUS)
 - Heterogeneously integrated photodiodes (BOOM)
- **Conclusion**

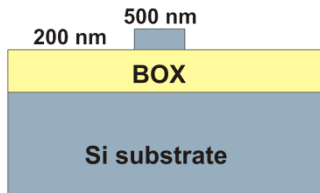
SOI platform

light wave
guiding and
processing
(optics - interference)
CMOS technology

SOI waveguides:

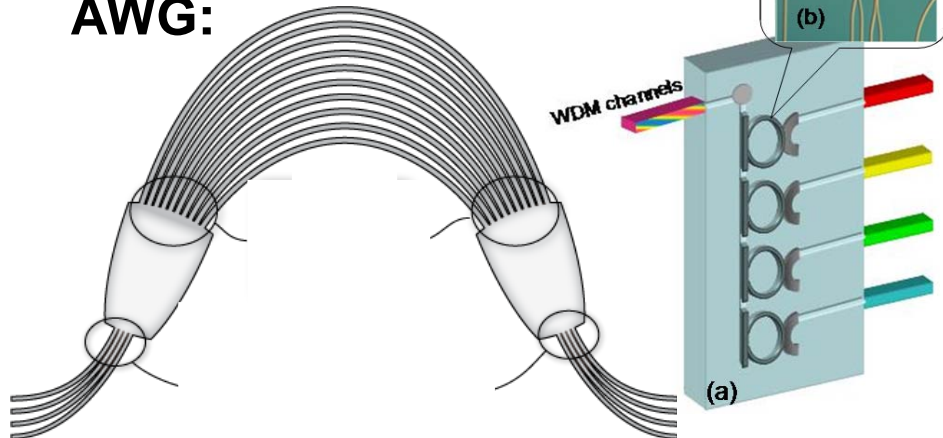


type "micro"



type "nano"

AWG:



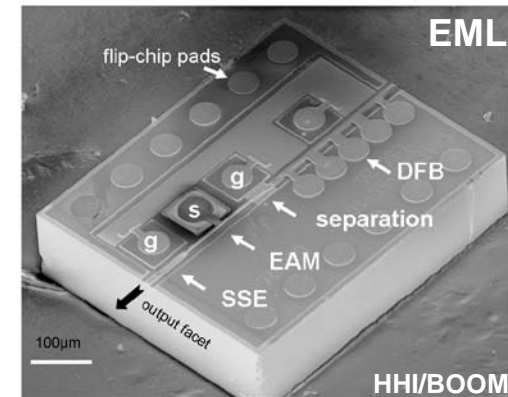
light detection,
modulation
and generation
(applied
Quantum Theory)

wavelength range: 1.3 μm ... 1.5 μm
(fibre based telecommunication)

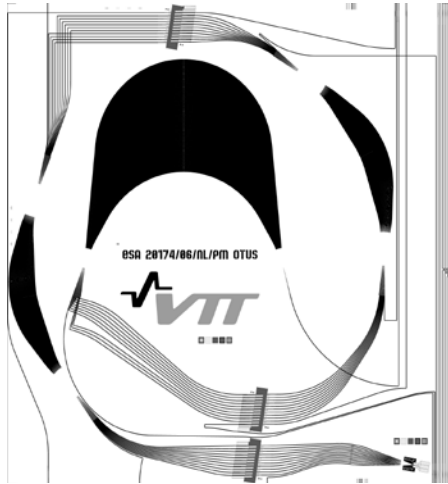
InP, InGaAsP,
InAlGaAs
InGaAs on InP

Waveguides,
photodiodes,
modulators: **Mach-Zehnder (MZI),**
electro-absorption (EAM),
semiconductor amplifiers (SOA)
lasers and integrated devices

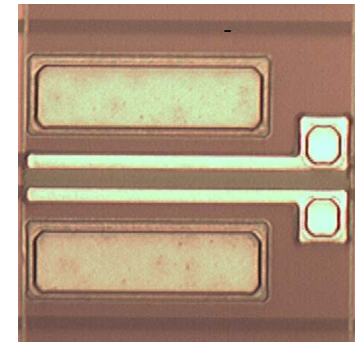
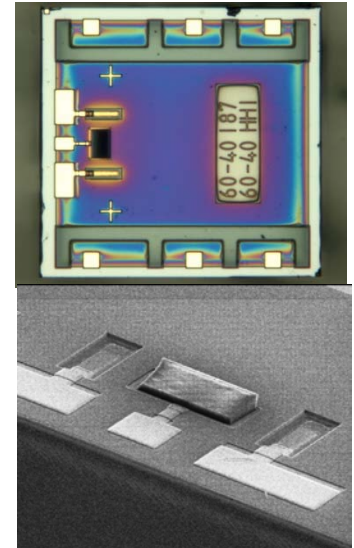
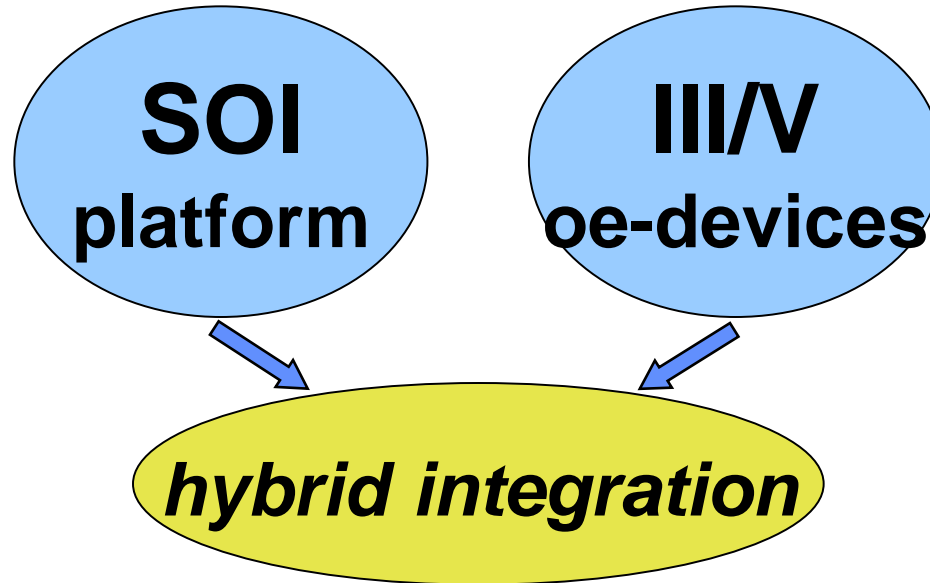
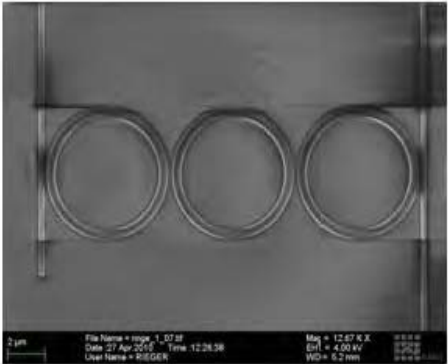
**III/V
oe-devices**



“micro”-waveguides:



“nano”-waveguides:

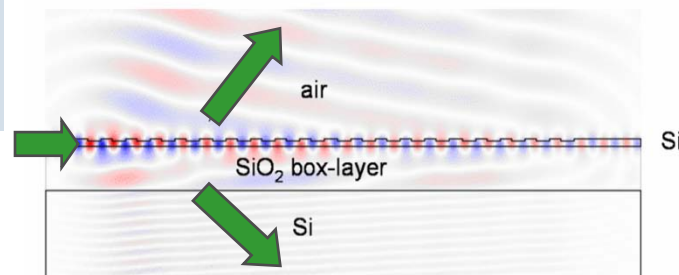
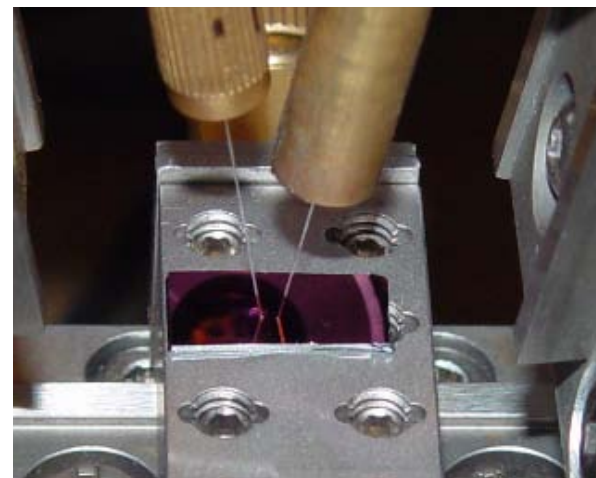
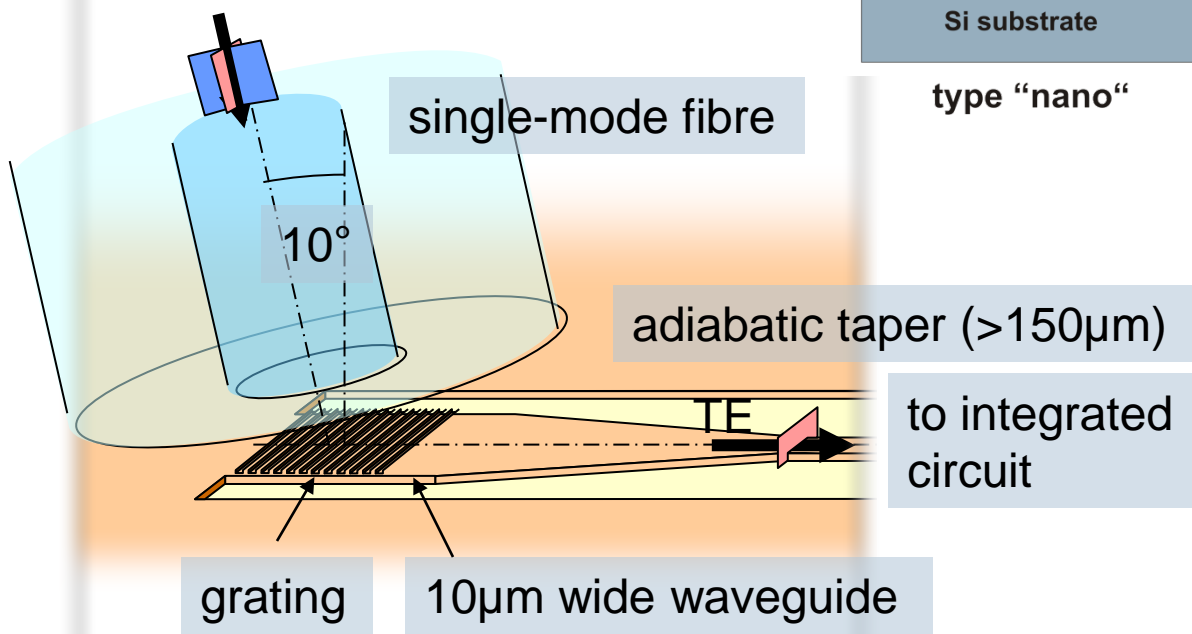


Integration, optical coupling → How?

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Coupling light into Si "nano" waveguides

Grating fiber couplers

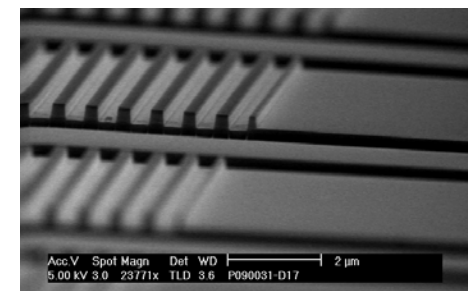


Efficiency

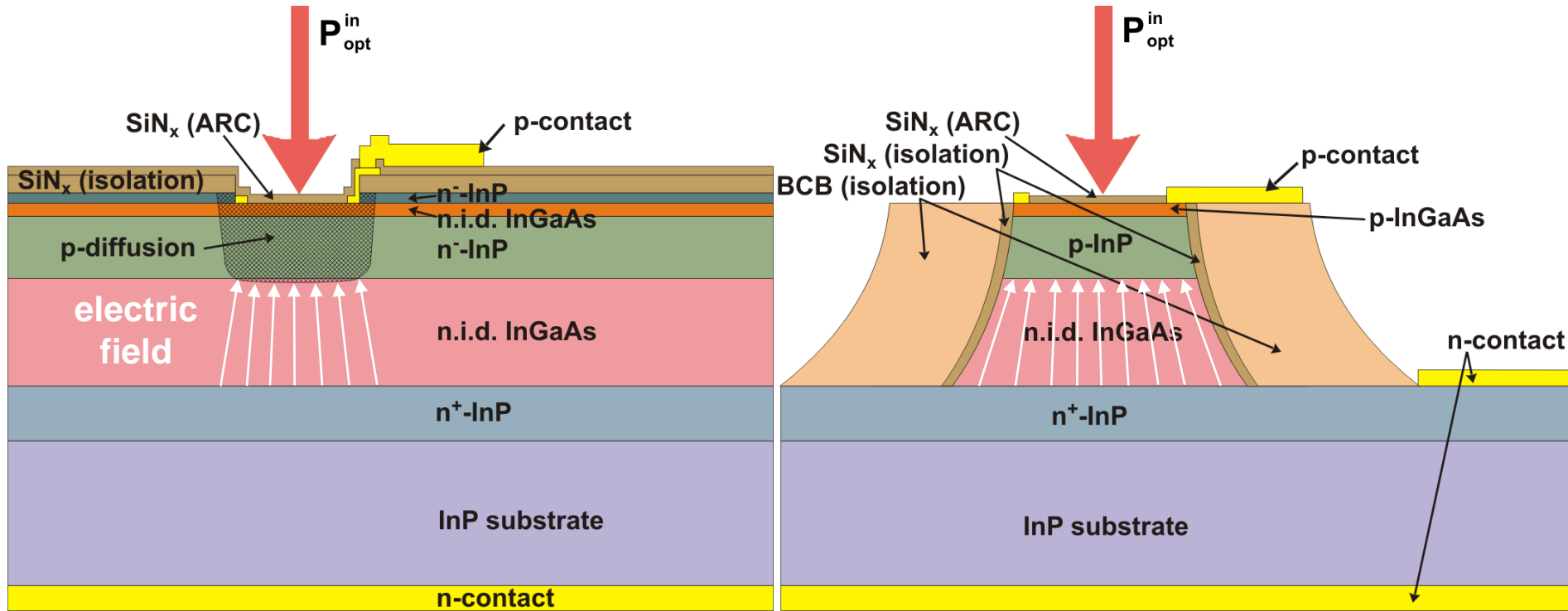
- Standard: 31 %
- With poly-silicon overlay: 68 %

D. Taillaert, JQE 7, p949 (2002)

D. Vermeulen, GFP09, PD1



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planar type

mesa type

How to make a high-speed PD

Bandwidth is depending on:

(K. Kato,1993.)

- The time it takes a carrier to drift across the depletion region

$$f_t = \frac{3.5v}{\pi d}$$

v = average speed holes and electrons
 d = thickness intrinsic layer

- The time it takes to charge and discharge the capacitance of the diode

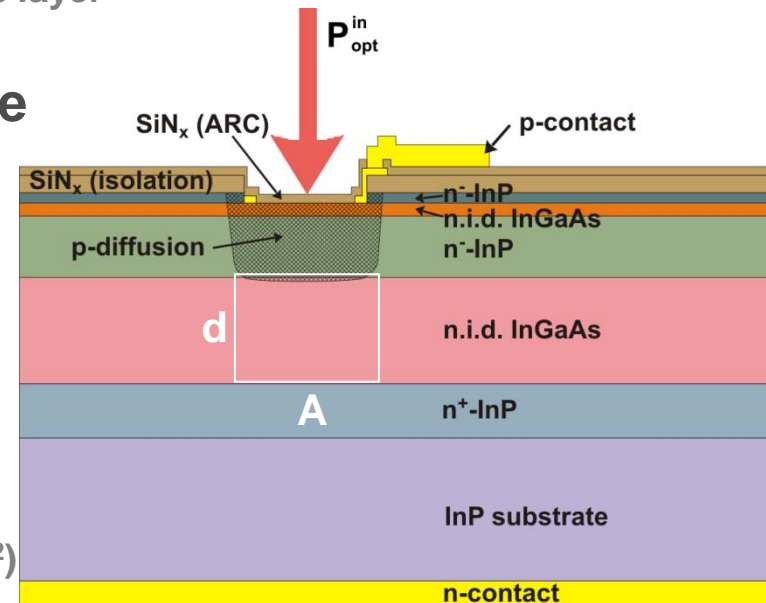
$$f_{RC} = \frac{1}{2\pi C(R_{load} + R_{contact})}$$

C = capacitance
 R = resistance

$$C = \frac{\epsilon_0 \epsilon_r A}{d}$$

$$R = \frac{k}{A}$$

A = area
 d = thickness intrinsic layer
 ϵ_r = relative permittivity
 k = contact resistance (Ohm.m²)

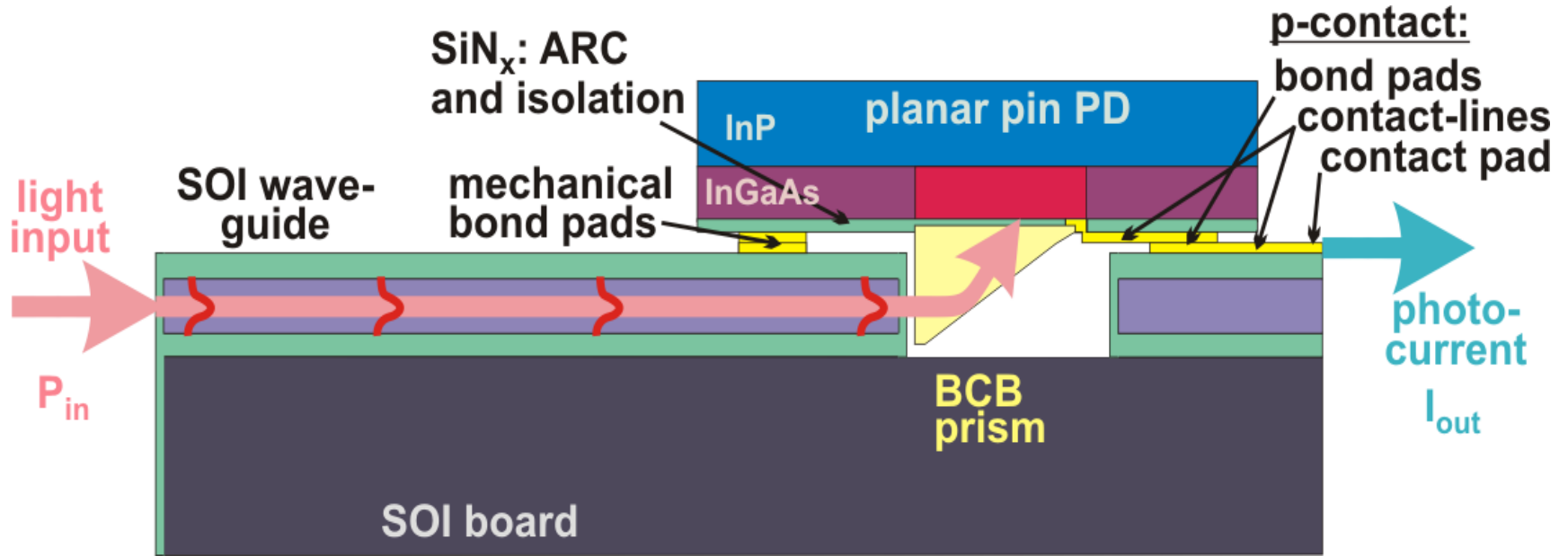


However: C is determined by active area *and* parasitics

Total 3-dB bandwidth:

$$\frac{1}{f_{3dB}^2} = \frac{1}{f_t^2} + \frac{1}{f_{RC}^2}$$

OTUS PD: Integration and optical coupling



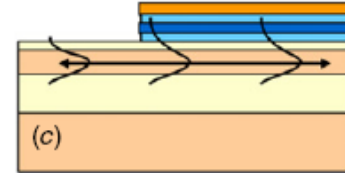
Requirements:

- **Compatible architectures (fabrication, integration)**
- **Effective optical coupling (high responsivity)**
- **Suitable for 10 Gb/s operation**
- **Independent of polarization and wavelength**

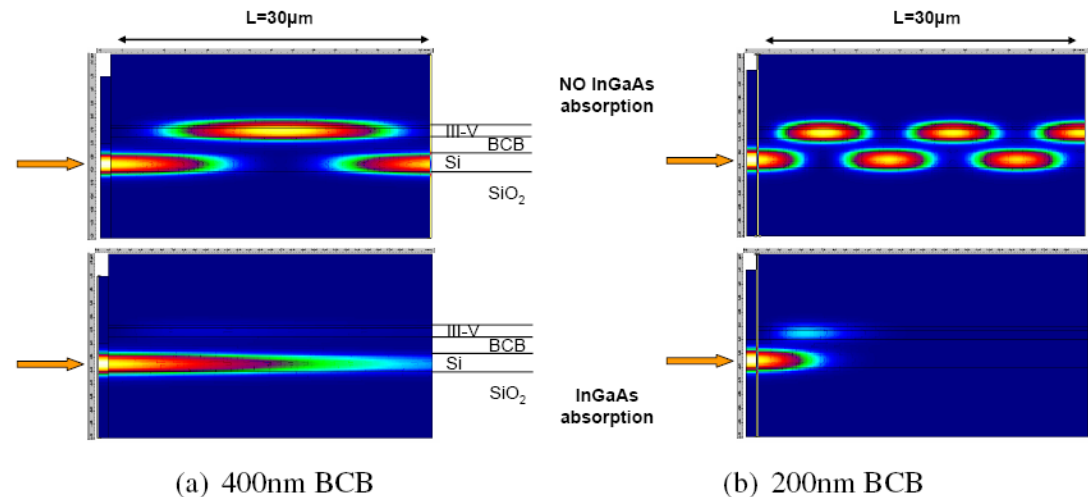
Light coupling Si "nano" waveguides/III-V PDs

Principle of evanescent coupling

- Coupled mode theory: power transfer from Si waveguide into III-V absorption layer
- For large & fast power transfer
 - Similar phase velocity \rightarrow small phase mismatch
 - Large mode overlap \rightarrow thin bonding layer
- Power transferred into the III-V layer is absorbed



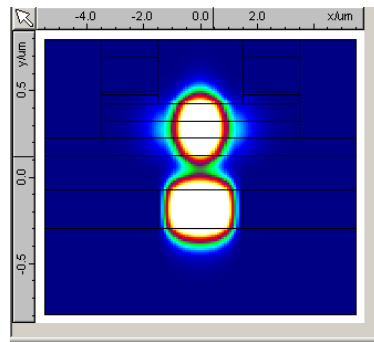
Example evanescently coupled PD:
Power transfer from silicon
layer to III-V layer



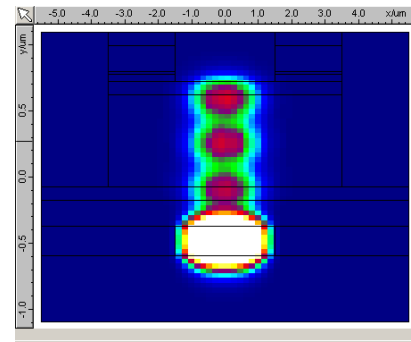
Increase high-speed performance

- Optimize trade-off RC-limit and transit-limit
 - Find optimum absorption layer thickness d

Thin InGaAs
- Coupling the 0th order

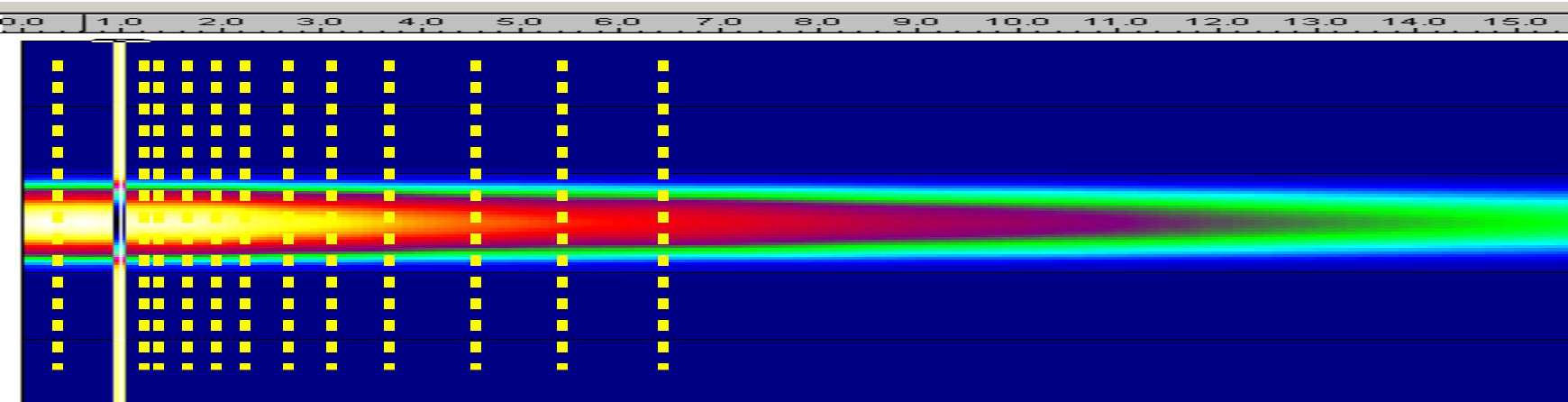
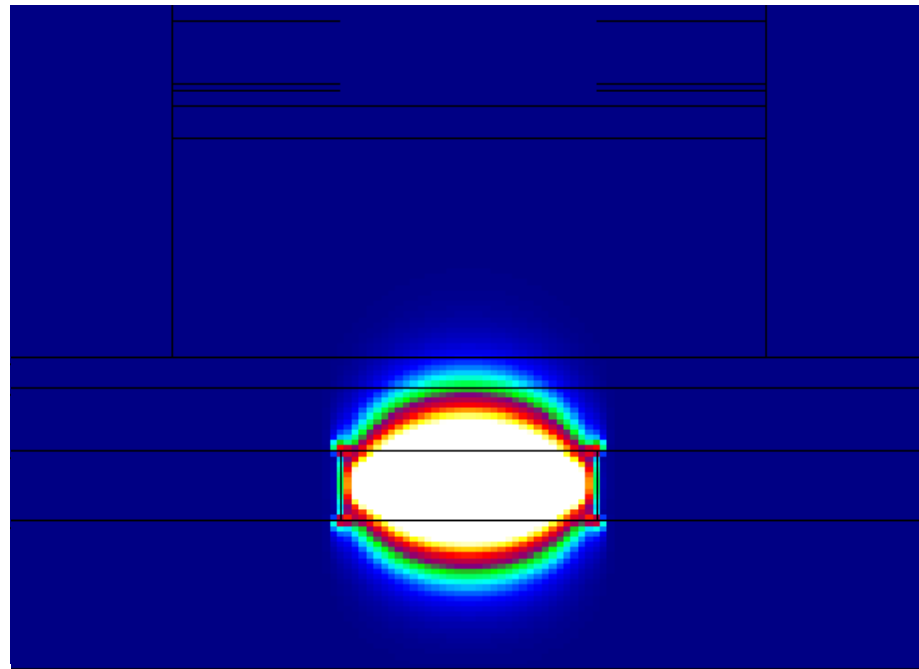


Thick InGaAs
- Coupling to 2nd order



- Optimize silicon waveguide for phase matching
 - High responsivity:
 - minimized metal contact absorption
 - Fast absorption:
 - short detector length for lower capacitance

Example: Simulating TM detector



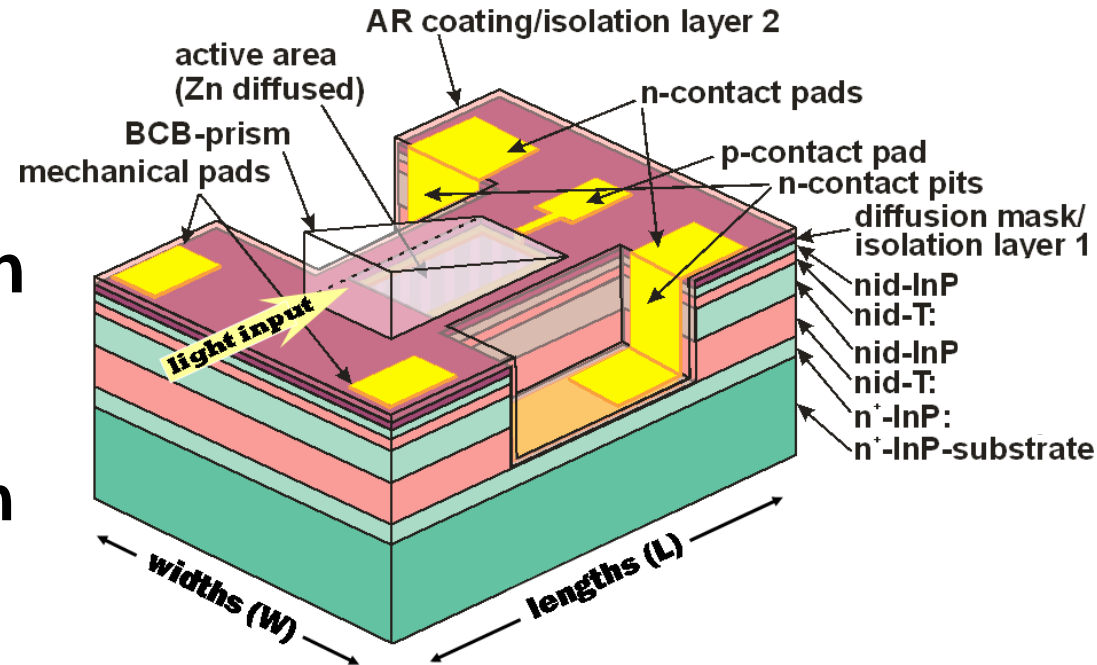
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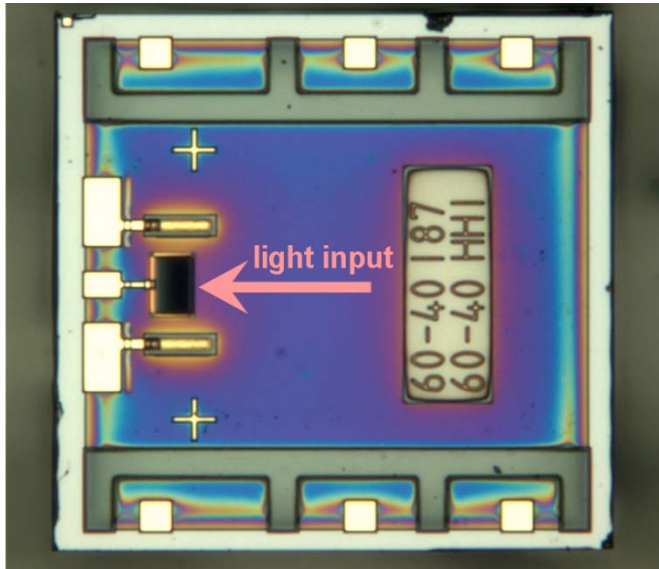
Standard photodiode processing sequence

+ BCB prism fabrication as add-on:

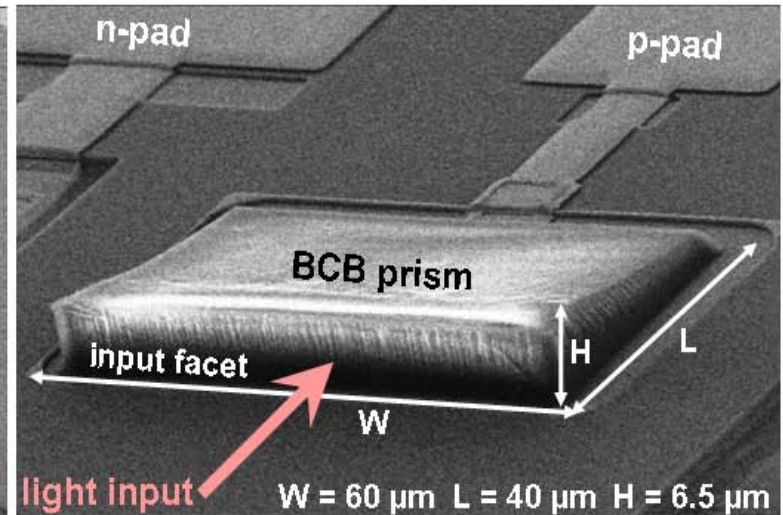
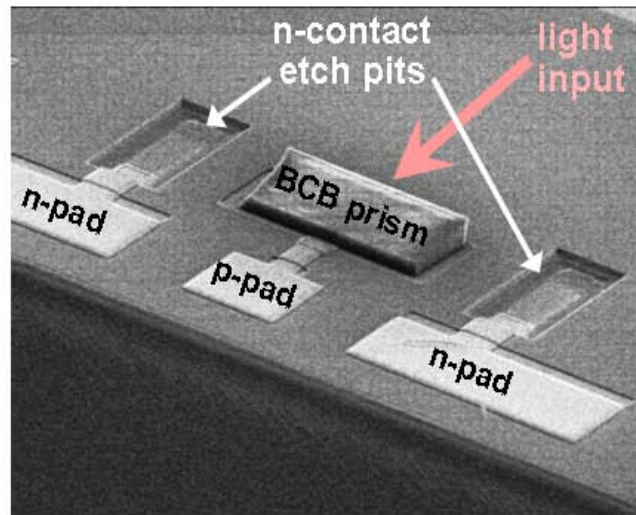
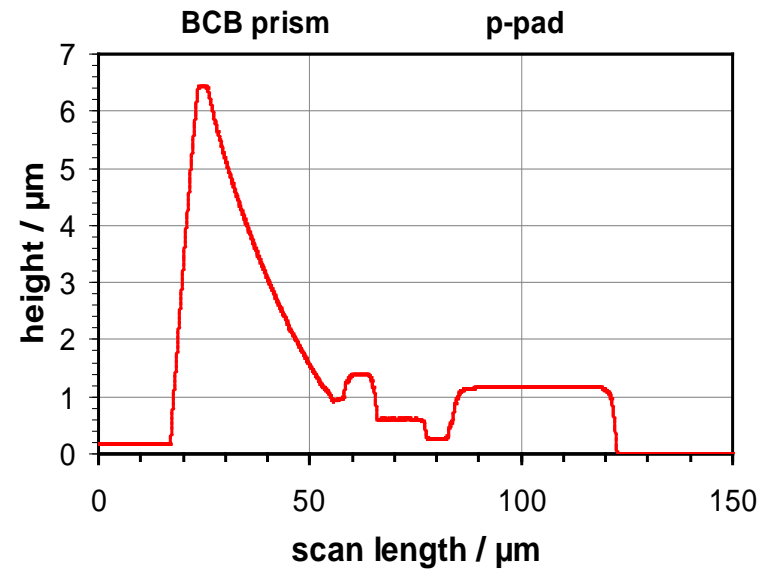
- ❶ BCB layer deposition and curing
- ❷ Lithography to produce a tapered resist mask (providing sliding mask technique)
- ❸ Relief transfer into BCB layer by RIE process (O_2 containing plasma)

➔ Advantage: “custom-made” prism shapes available



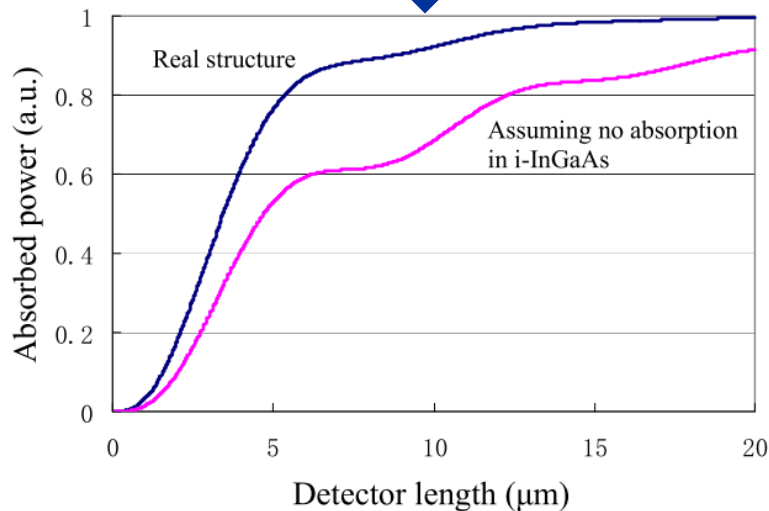
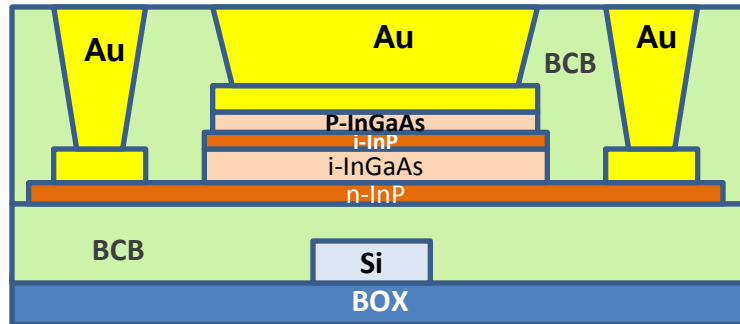


Chip
footprint:
500 x 500
 μm^2

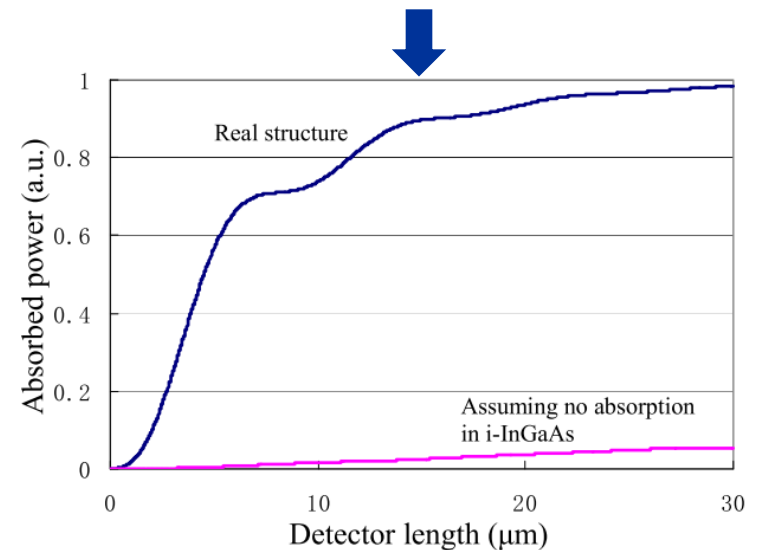
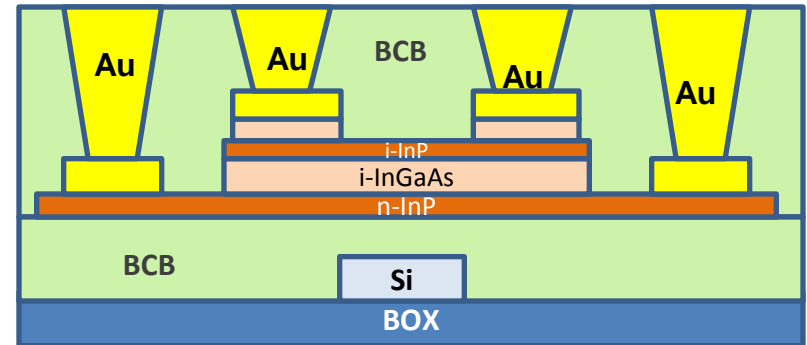


Photodiode design evanescent coupling

Old design



New design: the helmet

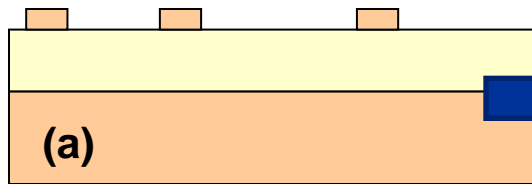


Improvement in responsivity by minimizing absorption in contact metal and p-doped InGaAs

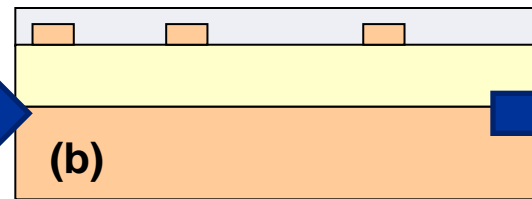
Z. Sheng, GFP, 2009

Heterogeneous integration

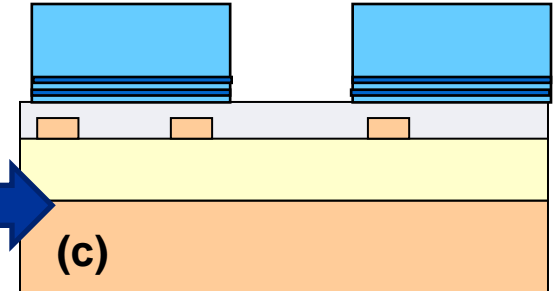
SOI-wafer



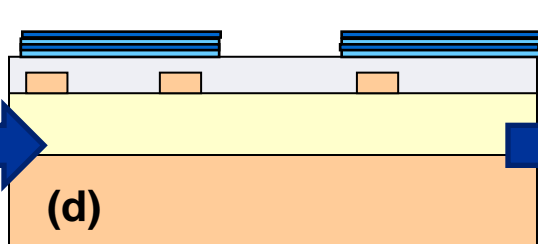
Planarization (BCB)



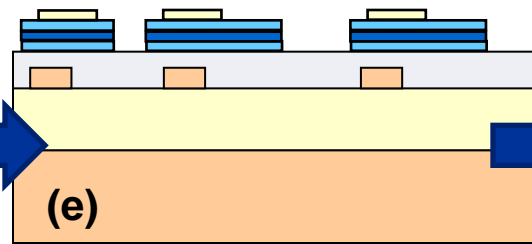
Bonding III-V die



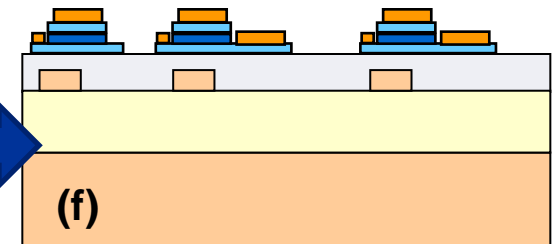
Substrate Removal



Pattern definition

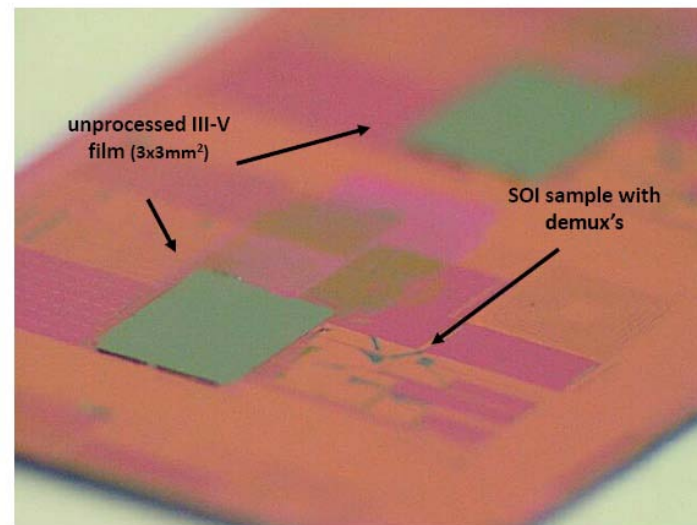


III-V processing

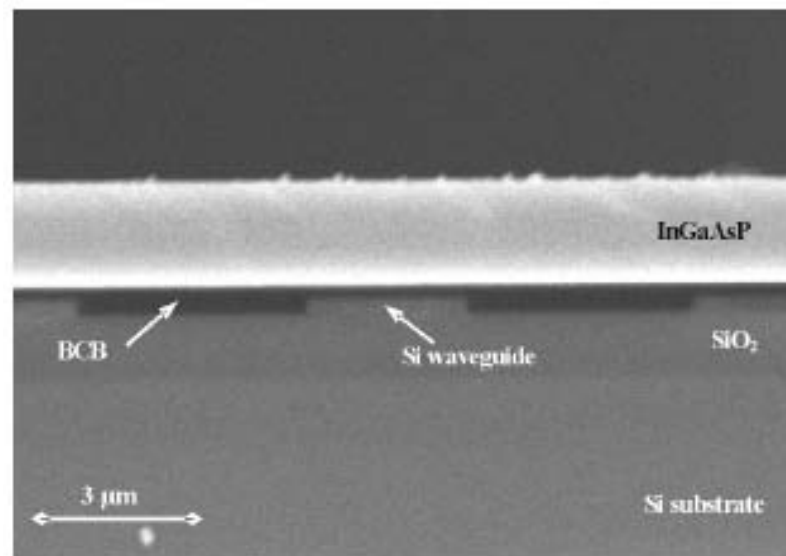


Heterogeneous integration examples

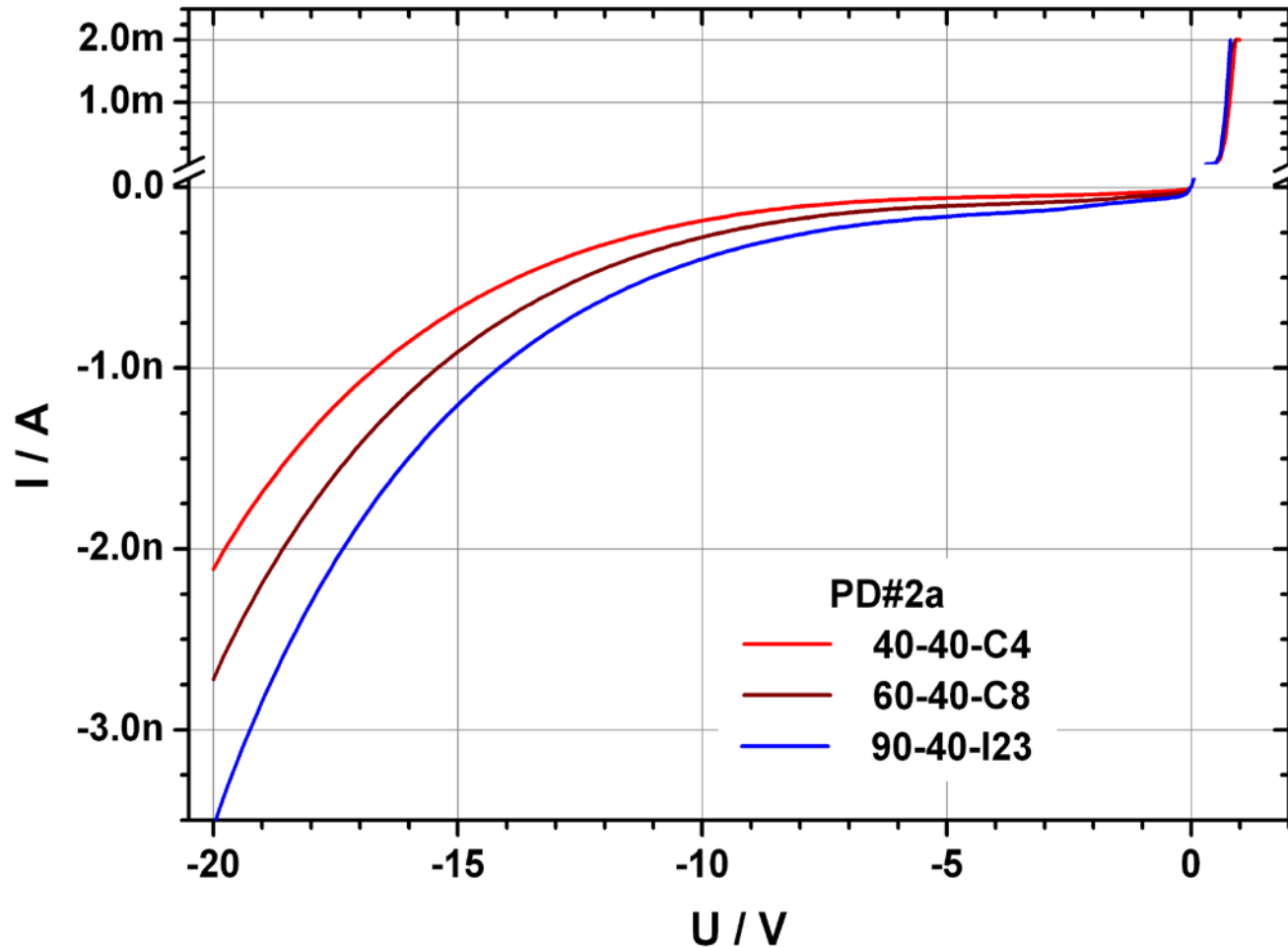
- Two unprocessed BCB bonded InP-based epitaxial layers (3 x 3 mm²) on top of an SOI substrate



- Cross-section SEM picture of a III-V film (after substrate removal) bonded on SOI using a 100 nm BCB layer

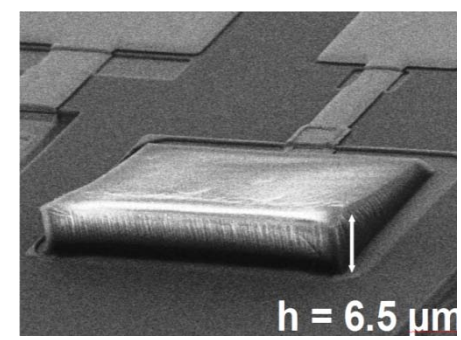
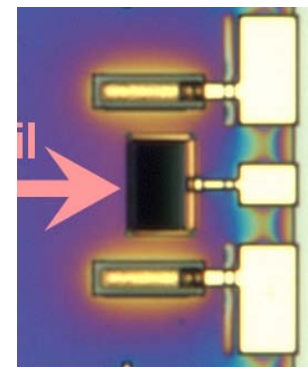
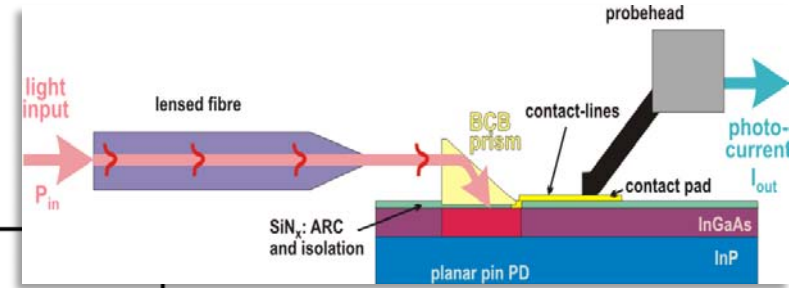
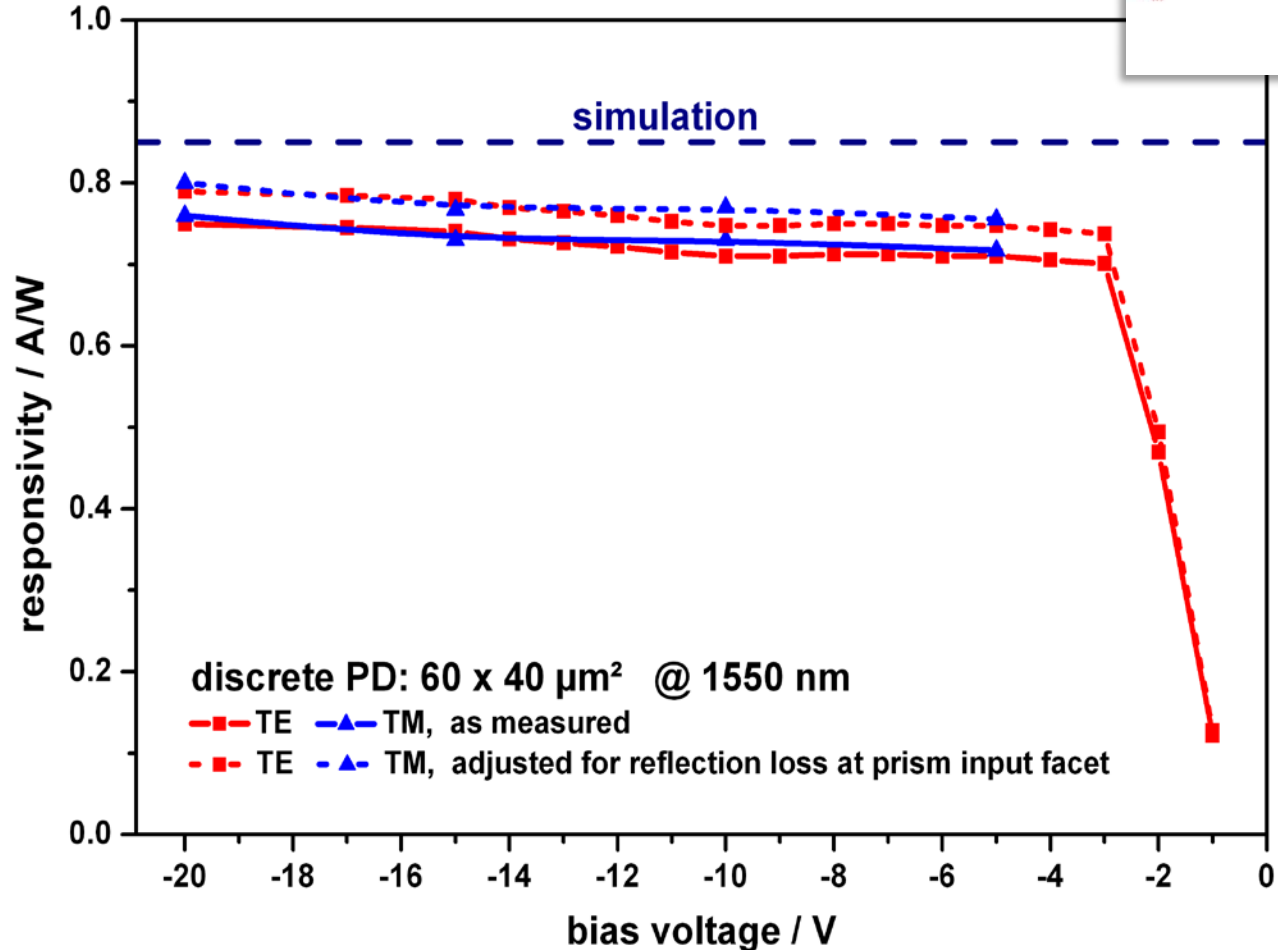


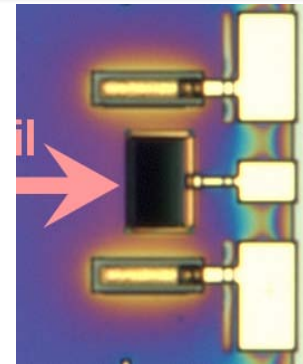
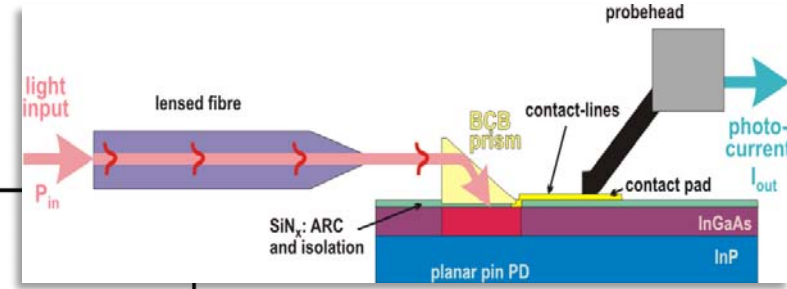
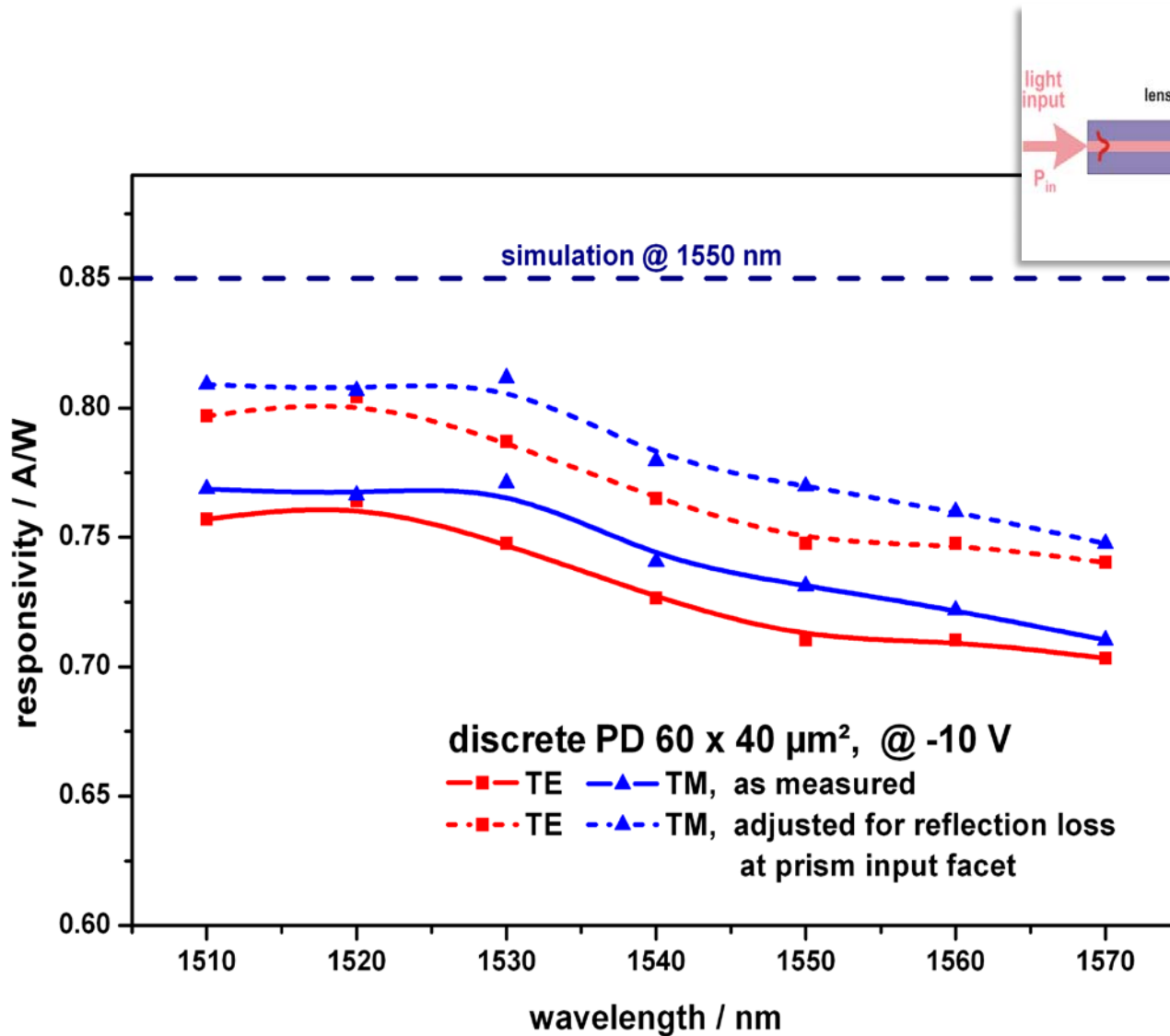
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Low dark currents
High breakdown voltages

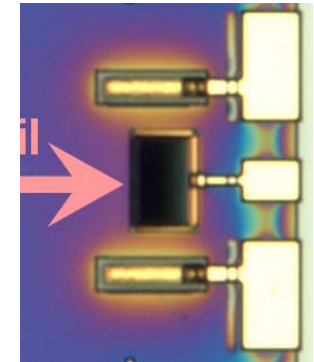
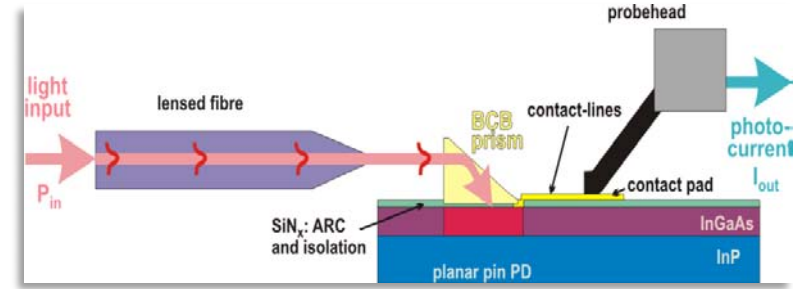
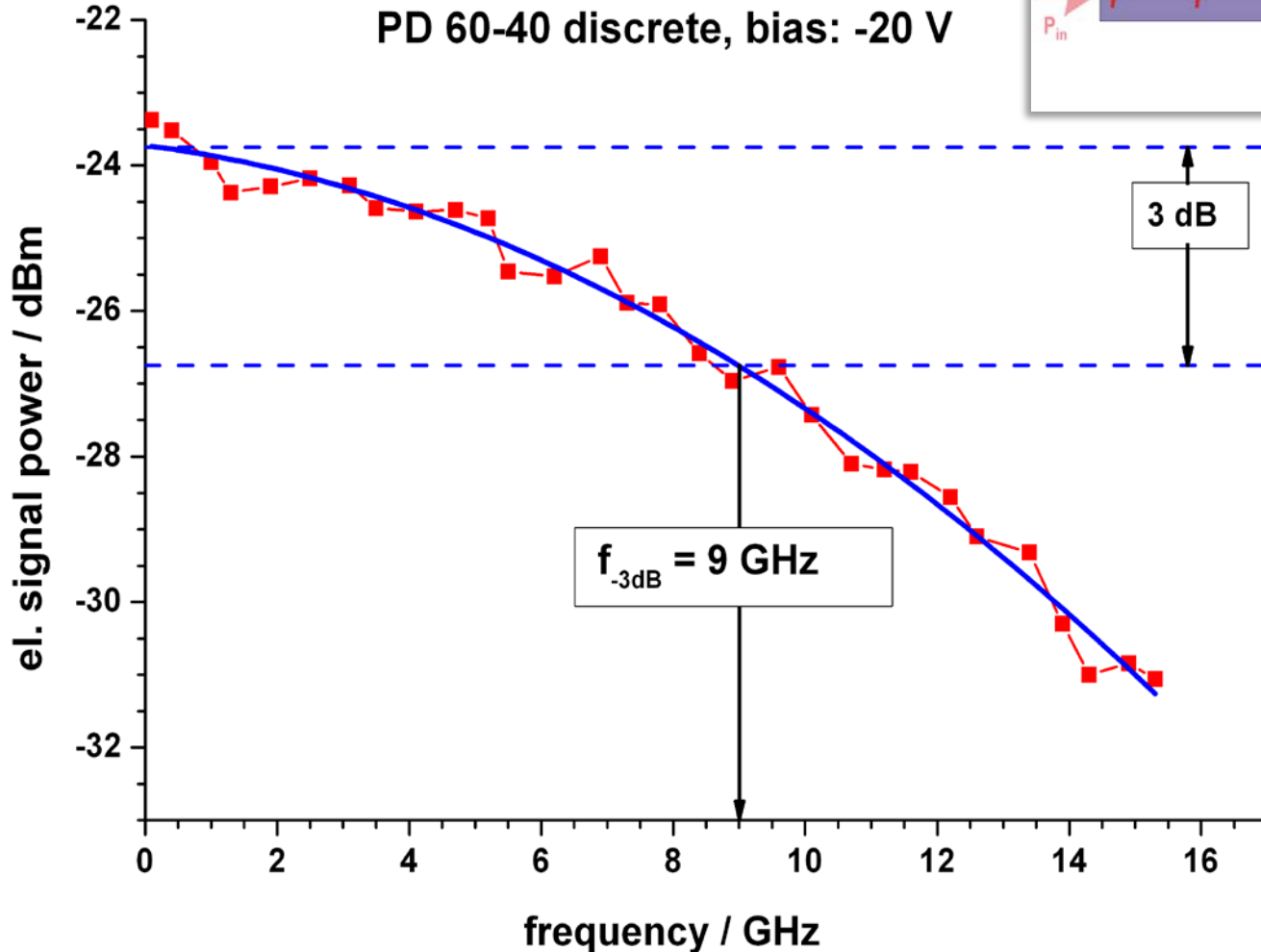
High responsivity





Weak dependence on wavelength and polarization

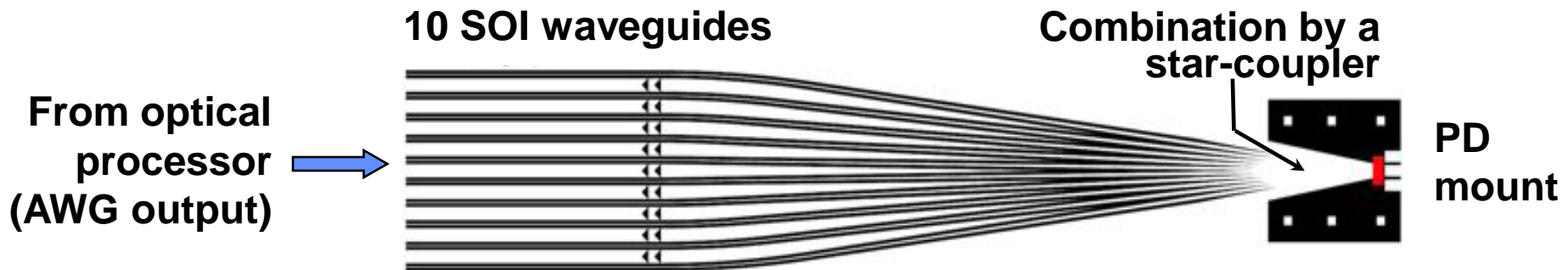
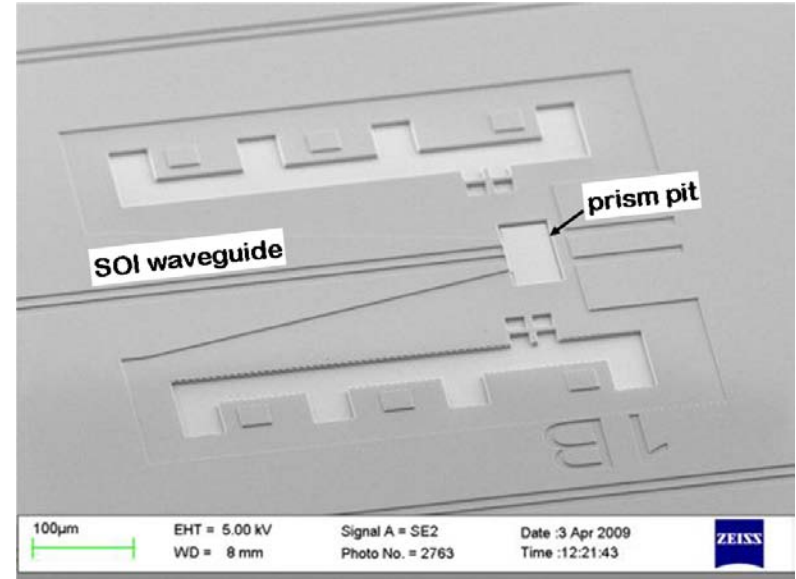
Photodiode performance – discrete chips (4)

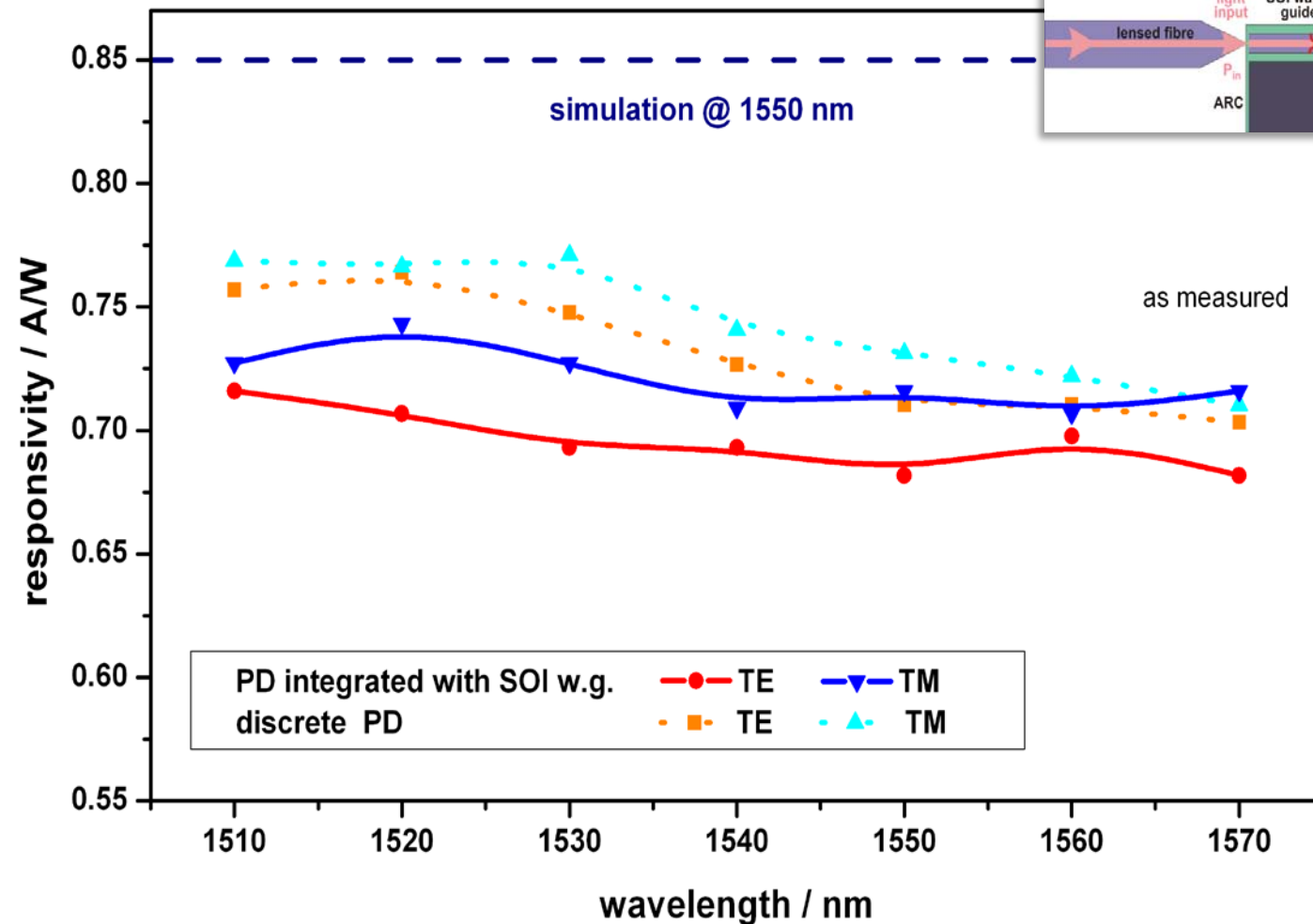
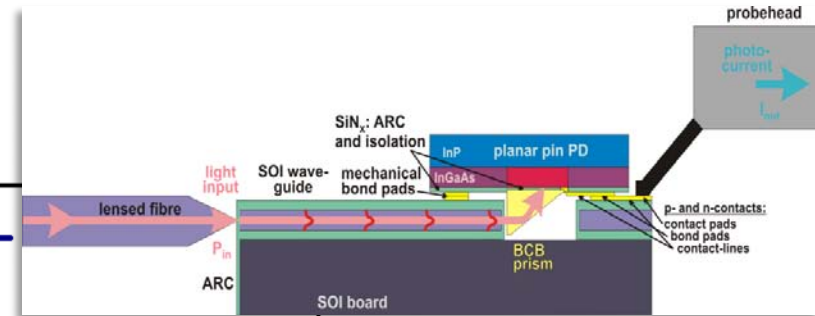


**Bandwidth
suitable for
10 Gb/s
operation**

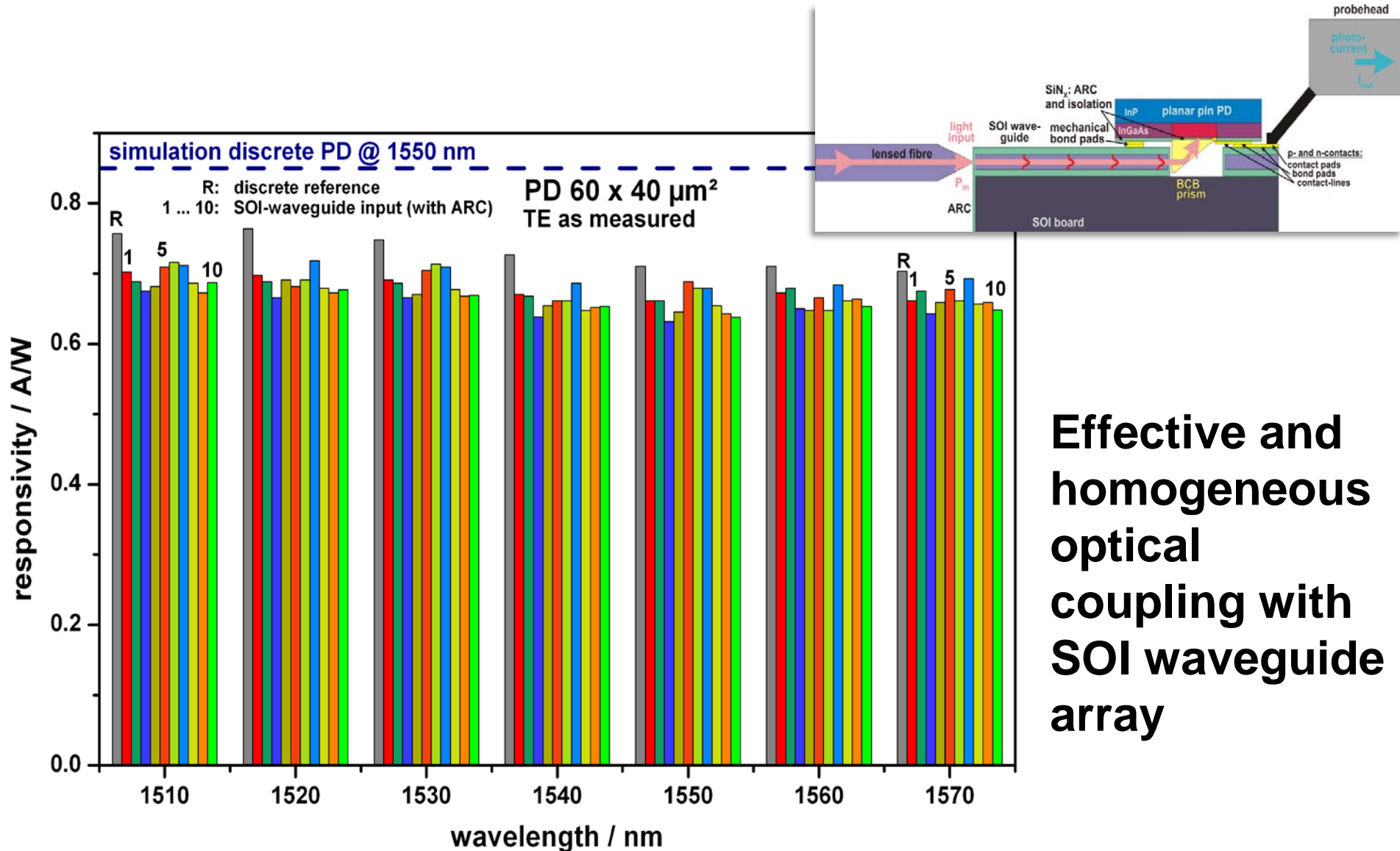
Demands on optical coupling:

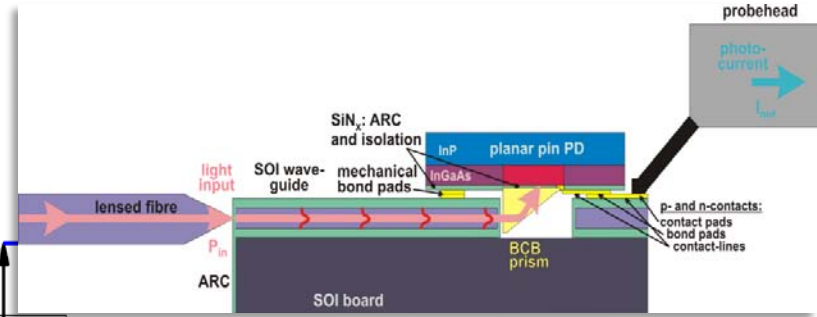
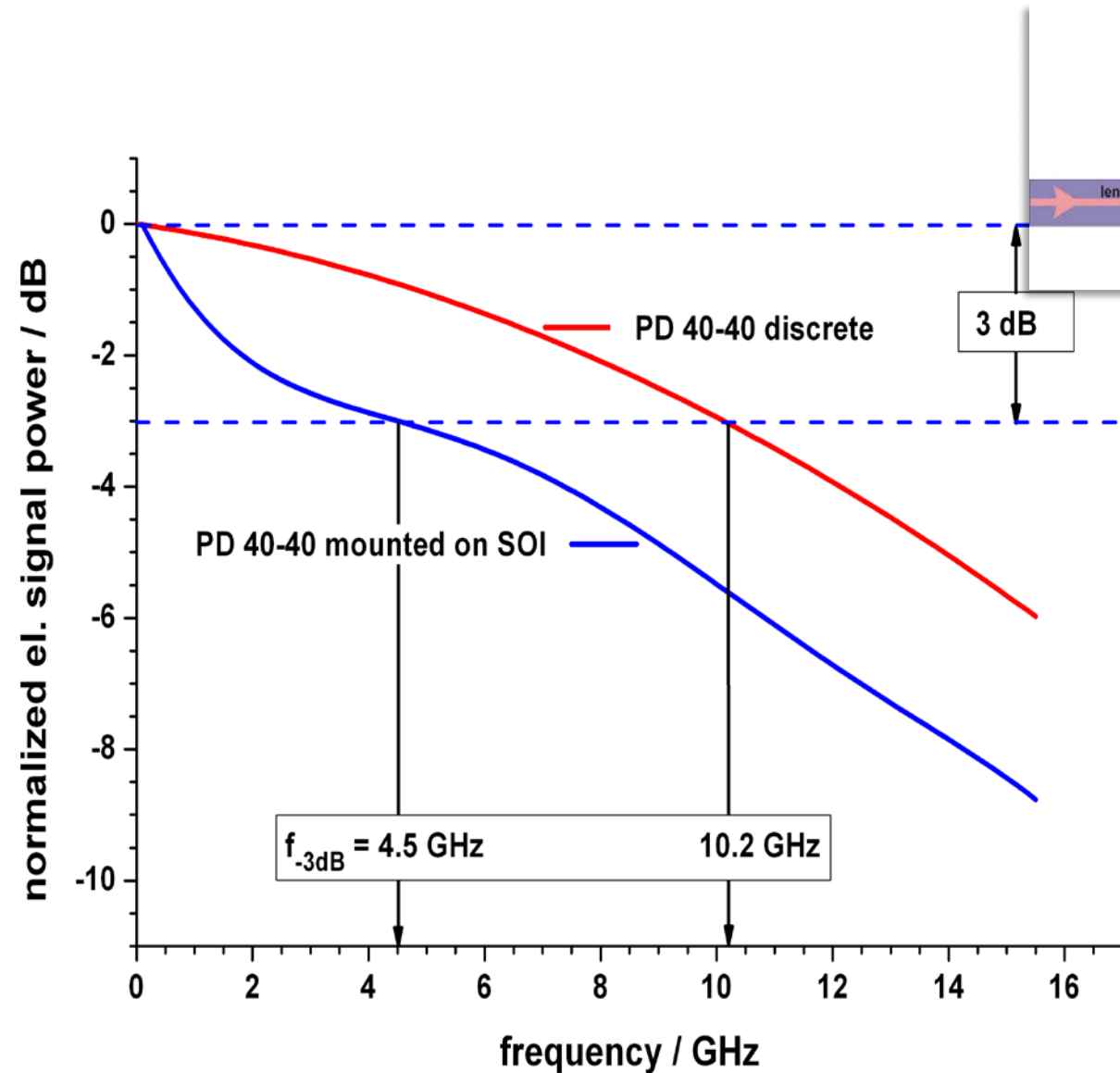
- high responsivity
 - independent on
 - wavelength
 - polarization
 - waveguide position
- high bandwidth for 10 Gb/s operation





Weak dependence on wavelength and polarization

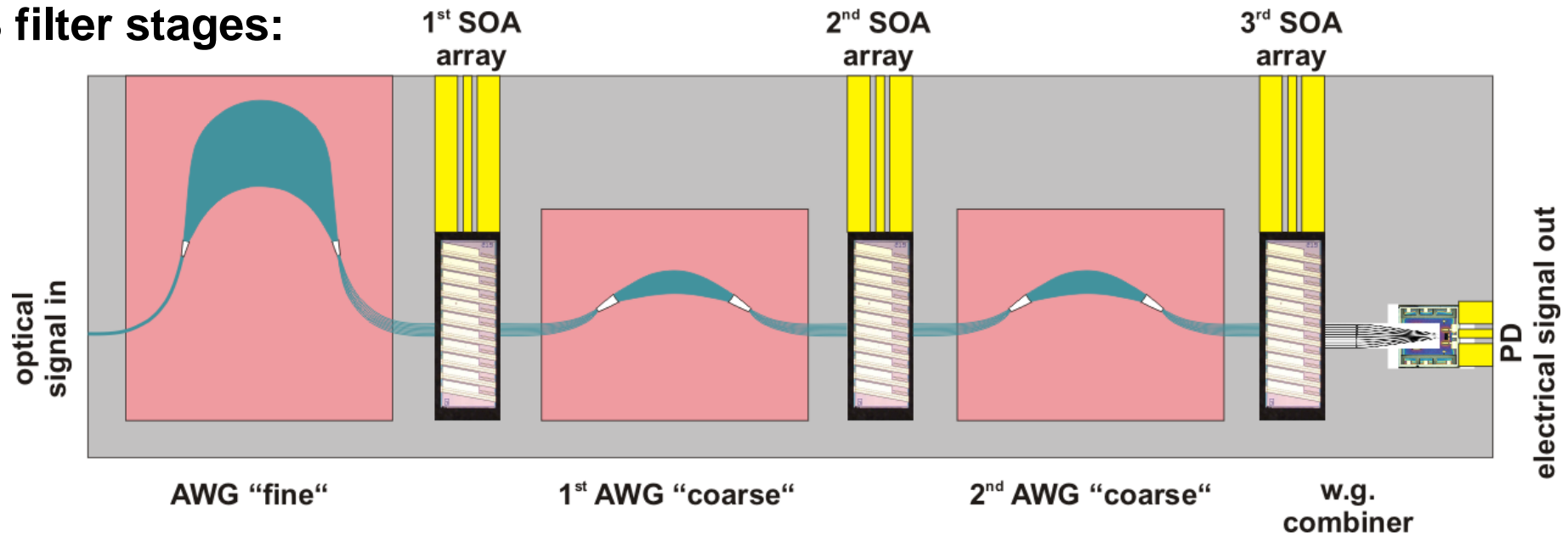




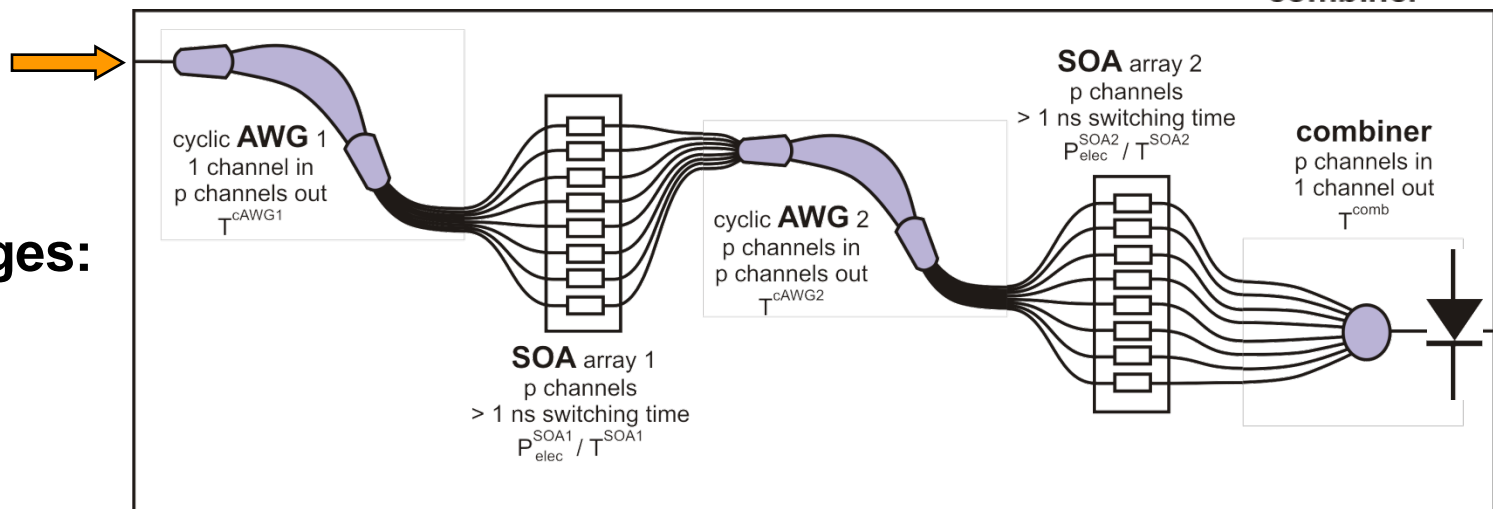
Degradation of bandwidth due to connection via RF line on low resistivity SOI

OTUS channel wavelength filter

3 filter stages:



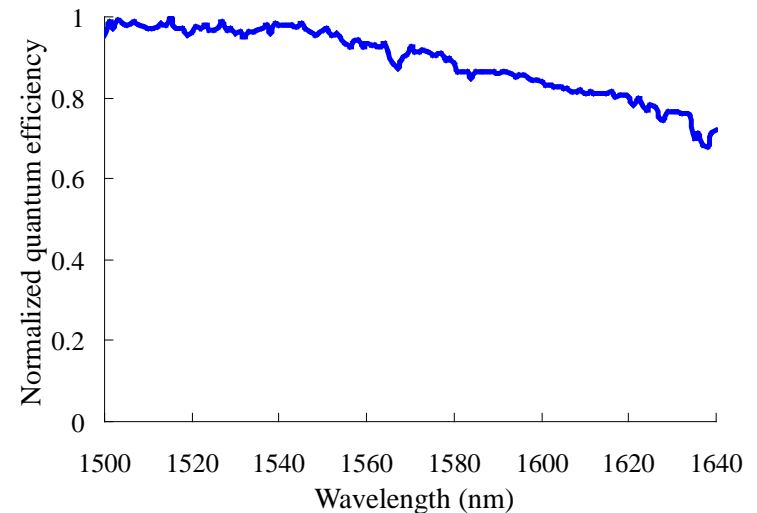
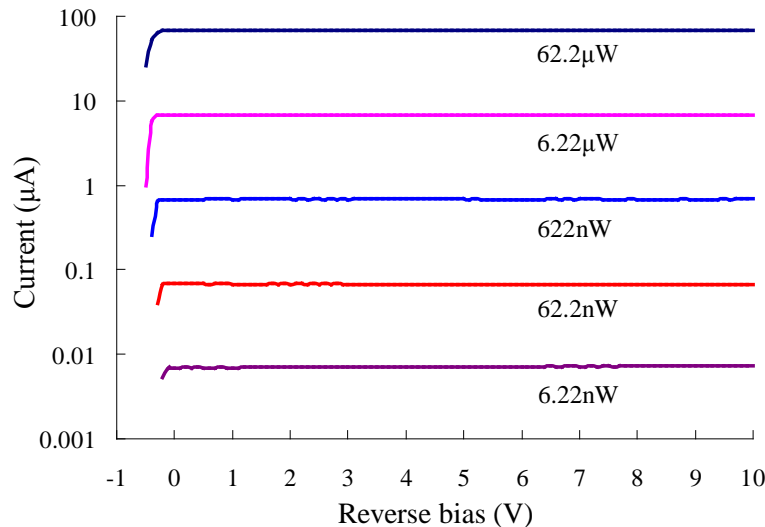
2 filter stages:



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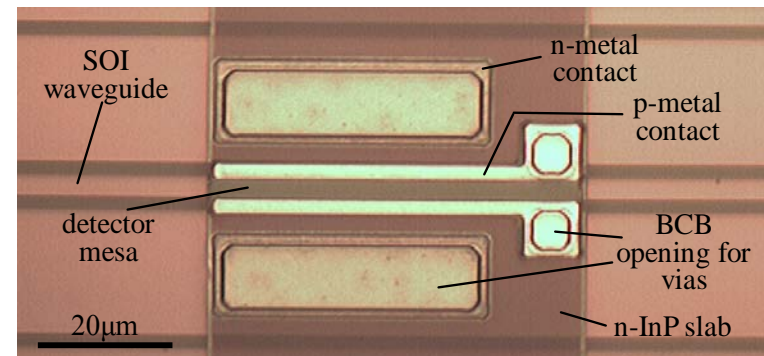
BOOM: Photodetector results

- High responsivity (1.1 A/W @ 1550 nm or 88 % quantum efficiency)
- Covering the whole S, C and L communication band
- Very low dark current 10 pA (needs very low bias voltage)



Top view (before final metallization)

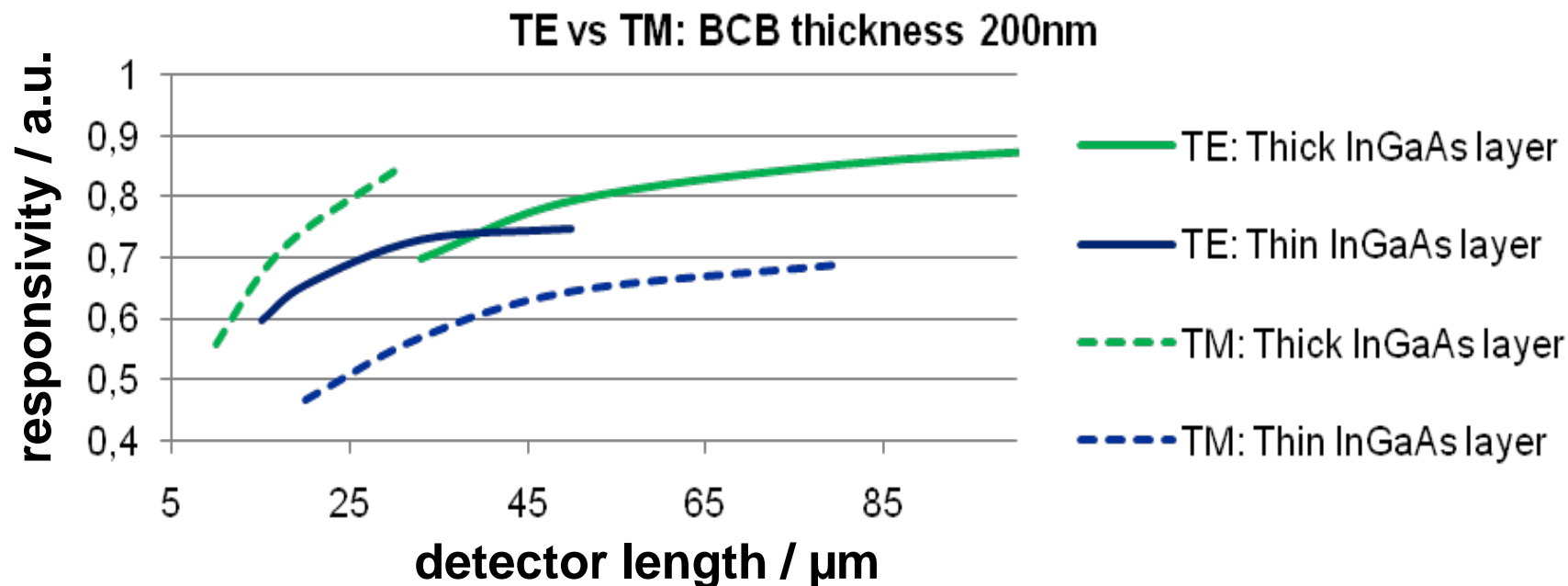
Z. Sheng, OpEx, vol 18(2), 2010



Increase high-speed performance

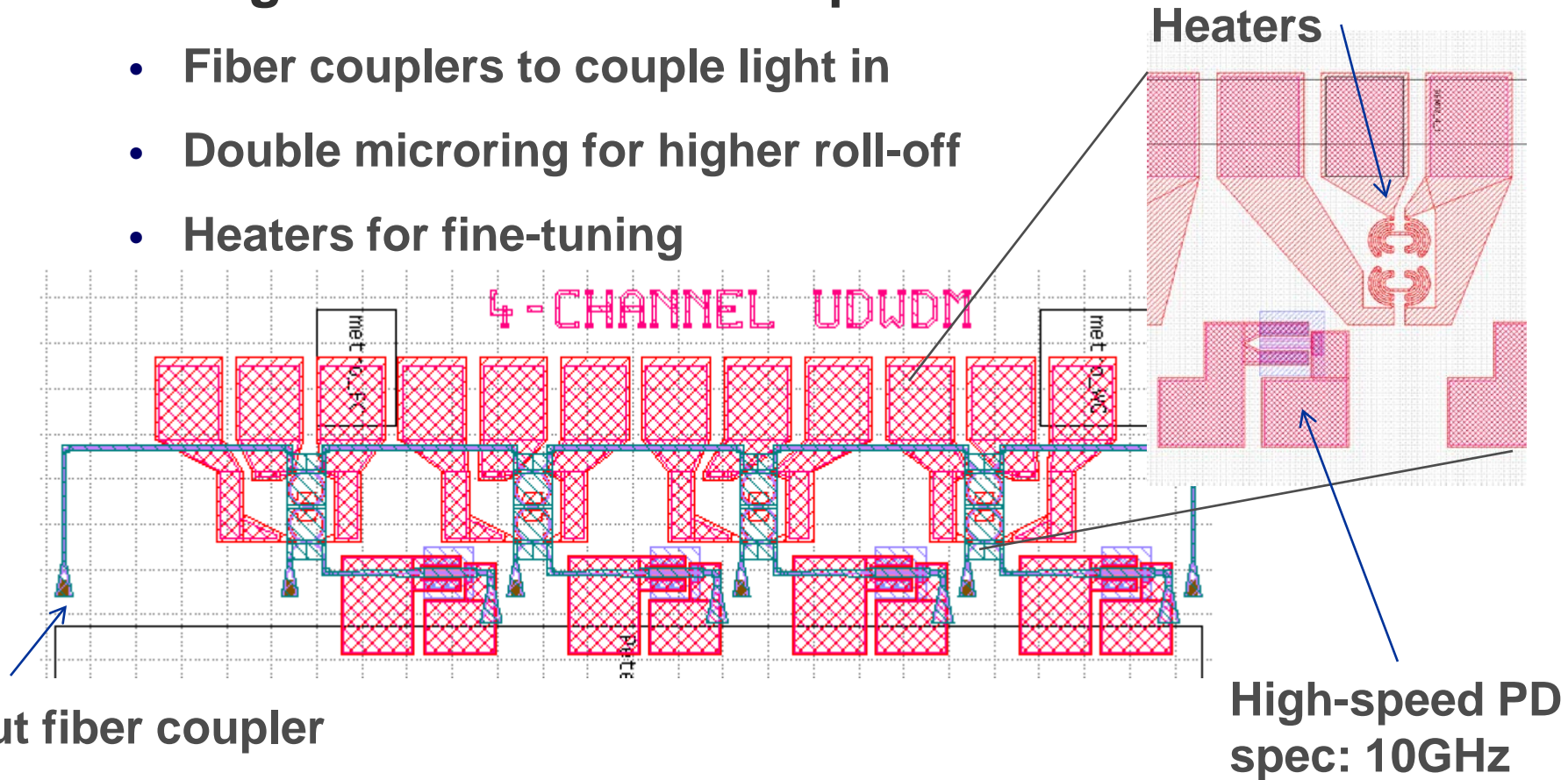
Performance is polarization dependent

- Thin InGaAs: TE higher responsivity & faster power transfer
- Thick InGaAs:
 - TM has a faster power transfer
 - Both polarizations have higher responsivity



BOOM: UDWDM Demultiplexer

- Design: 4-channel demultiplexer
 - Fiber couplers to couple light in
 - Double microring for higher roll-off
 - Heaters for fine-tuning



- Fabrication underway

- **Successful integration of InP based photodiodes with SOI waveguides via two approaches:
prism coupling and evanescent coupling**
- **Prism coupling via a BCB prism as add-on on standard photodiode structure:
effective, easy to fabricate.**
- **Evanescent coupling via InGaAs dies, heterogeneously integrated on top of SOI “nano” waveguides:
effective, more sophisticated design and technology**
- **Both approaches show high responsivity with low dependence on wavelength, suitable for 10 Gb/s operation**

This work has been funded by:



Optical Technologies for Ultra-fast Processing

European Space Agency (ESA) under ESTEC contract No 20174/06/NL/PM (OTUS, ARTES5)



Terabit-on-chip:

Micro- and Nano-scale silicon photonic integrated components and sub-systems enabling Tb/s-capacity, scalable and fully integrated photonic routers



European Commission, STREP - 7th framework programme (ICT-2007-2, Contract no. 224375)

With special thanks to Klemens Janiak